

<b>Notice of References Cited</b>			Application/Control No. 09/903,630	Applicant(s)/Patent Under Reexamination CHUNG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,505,160	01-2003	Levy et al.	704/270
*	B	US-2002/0052933 A1	05-2002	Leonhard et al.	709/219
*	C	US-6,226,655 B1	05-2001	Borman et al.	715/501.1
*	D	US-6,618,335 B2	09-2003	Tanaka et al.	369/53.21
*	E	US-6,810,200 B1	10-2004	Aoyama et al.	386/94
*	F	US-2001/0044838	11-2001	Iida, Sachio	709/219
*	G	US-2001/0005838	06-2001	So, Hirokazu	705/57
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP11-296587	10-1999	Japan	Honda et al.	G06F 17/60
*	O	JP2000-322353	11-2000	Japan	Takeuchi et al.	G06F 13/00
*	P	WO 00/45303	08-2000	U.S.	Lara et al.	G06F 17/30
*	Q	WO 1/08021 A1	02-2001	U.S.	Madison	G06F 15/16
*	R	JP11-341440	12-1999	Japan	Ishibashi	H04n 5/93
*	S	JP2001-42866	02-2001	Japan	Hasegawa et al.	G10H 1/00
*	T	JP2001-60179	03-2001	Japan	Nakatsu	G06F 13/00

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Japanese Office Action, 6/1/2004
*	V	Japanese Office Action, 1/27/2004 for corresponding Japanese Patent Application No. 2001-246689
*	W	RealJukebox 2 Plus Manual, Chapters 2 and 4, 2000.
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP2000-308025	11-2000	Japan	Kitazato	H04N 7/08
*	O	JP 7-296508	11-1995	Japan	Sekiya et al.	G11B 20/10
*	P	JP 8-160855	06-1996	Japan	Takashima et al.	G09C 1/00
*	Q	JP 8-153331	06-1996	Japan	Koriyama	G11B 7/007
*	R	JP 10-177767	06-1998	Japan	Tanaka	G11B 20/10
*	S	JP 10-21263	01-1998	Japan	Hirayama et al.	G06F 15/40
*	T	JP 9-214923	08-1997	Japan	Nishioka	H04N 7/15

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 98/03923	06-1997	U.S.	Kraftsow et al.	G06F 15/163
*	O	WO 00/65509	04-2000	U.S.	Miller et al.	G06F 17/60
*	P	WO 99/55055	04-1999	U.S.	Kupka et al.	H04L 29/06
*	Q	KR 2000-71986	12-2000	Korea	Chung et al.	
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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